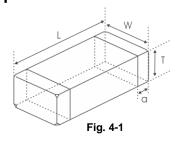


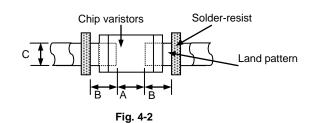
Electrical Characteristics

Please refer to Appendix A (Page 9~13).

- 1) Operating and storage temperature range (individual chip without packing): -55 $^{\circ}$ C ~ +125 $^{\circ}$ C.
- 2) Storage temperature range (packaging conditions): -10°C~+40°C RH 70% (Max.).

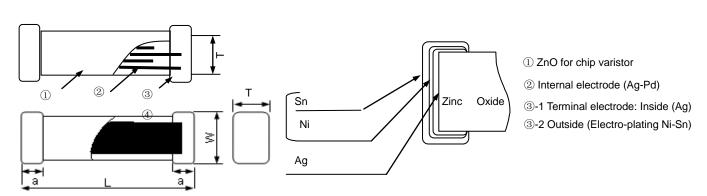
Shape and Dimensions





Unit: mm [inch]

Туре	L	W	Т	а	А	В	С
1005 [0402]	1.0±0.15 [0.039±0.006]	0.5±0.15 [0.020±0.006]	0.5±0.15 [0.020±0.006]	0.25±0.1 [0.010±0.004]	0.45~0.55	0.40~0.50	0.45~0.55
1608 [0603]	1.6±0.15 [0.063±0.006]	0.8±0.15 [0.031±0.006]	0.8±0.15 [0.031±0.006]	0.3±0.2 [0.012±0.008]	0.60~0.80	0.60~0.80	0.60~0.80
2012 [0805]	2.0±0.2 [0.079±0.008]	1.25±0.2 [0.049±0.008]	0.85±0.2 [0.033±0.008]	0.5±0.3 [0.020±0.012]	0.80~1.20	0.80~1.20	0.90~1.60
3216 [1206]	3.2±0.2 [0.126±0.008]	1.6±0.2 [0.063±0.008]	0.85±0.2 [0.033±0.008]	0.5±0.3 [0.020±0.012]	1.80~2.50	1.00~1.50	1.20~2.00



Part Number	Max. Working Voltage		Varistor Voltage		Clamping Itage	Rated Sin Trans	•	Typical Capacitance
Test Condition	C C	0μA AC RMS	@1mA DC	8/20µs	ESD	Energy 10/1000µs	Peak Current 8/20µs	@0.5V _{rms} , 1MHz
Units	Volts	Volts	Volts	Volts	Volts	Joules	Amps	pF
Symbol	V_{WDC}	V_{WAC}	V_{B}	V _C *1	V _C *2	E _T	Ι _P	С
TESB0R15V05B1X	5	12.7	31.0-38.0	58	70	0.003	1	3



Test and Measurement Procedures

Test Conditions

Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a. Ambient Temperature: 20±15℃.
- b. Relative Humidity: 65±20%.
- c. Air Pressure: 86kPa to 106kPa.

If any doubt on the results, measurements/tests should be made within the following limits:

- a. Ambient Temperature: 20±2℃
- b. Relative Humidity: 65±5%.
- c. Air Pressure: 86kPa to 106kPa.

Visual Examination

a. Inspection Equipment: 20× magnifier.

Electrical Test

Items	Requirements	Test Methods and Remarks	
Refer to Appendix A		Measuring current: 1mA DC Duration: 0.2 to 2 sec	
Capacitance (C)	Refer to Appendix A	Measure source: 0.5 V _{RMS} Test frequency: 1MHz.	
Leakage Current (I _L)	Refer to Appendix A	Measuring voltage: Maximum DC working voltage	
Clamping Voltage (V _C)	Refer to Appendix A	Measuring source: 8/20us waveform, ESD waveform	

Reliability Test

Items	Requirements	Test Methods and Remarks
Terminal	No removal or split of the termination or other defects shall occur.	① Solder the chip to the testing jig (glass epoxy board shown in Fig.5.4.1-1) using eutectic solder. Then apply a force in the
Strength	Chip	direction of the arrow.
	F	② Keep time: 10±1s.
	Mounting Pad Glass Epoxy Board	
	Fig.5.4.1-1	

-	T				
Resistance to	No visible mechanical damage.	Solder the chip to the test jig (glass epoxy board shown in			
Flexure	Type a b c	Fig.3.4.2-1) using a eutectic solder. Then apply a force in the			
	1005[0402] 0.4 1.5 0.5	direction shown in Fig.3.4.2-2 . ② Flexure: 2mm.			
		Pressurizing Speed: 0.5mm/sec.			
	1608[0603] 1.0 3.0 1.2	④ Keep time: 30 sec.			
	2012[0805] 1.2 4.0 1.65				
	3216[1206] 2.2 5.0 2.0				
	Unit: mm [inch]	10 ± 10			
	_b Ф4.5	R230 7			
	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				
		Flexure			
	4	45[1.772] 45[1.772]			
	100 → Fig.3.4.2-1	Fig. 5.42.2			
	1 19.5.4.2-1	Fig.5.4.2-2			
Vibration	No visible mechanical damage.	Solder the chip to the testing jig (glass epoxy board shown in			
		Fig.3.4.3-1) using eutectic solder.			
	Cu pad Solder mask	The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly			
	ta a a la	between the approximate limits of 10 and 55 Hz.			
		③ The frequency range from 10 to 55 Hz and return to 10 Hz shall			
		be traversed in approximately 1 minute. This motion shall be			
		applied for a period of 2 hours in each 3mutually perpendicular			
	Glass Epoxy Board Fig. 3.4.3-1	directions (total of 6 hours).			
Solderability	No visible mechanical damage.	① Solder temperature: 240±2℃			
	② Wetting shall exceed 90% coverage.	② Duration: 3 sec.			
		③ Solder: Sn/3.0Ag/0.5Cu.			
D		Flux: 25% Resin and 75% ethanol in weight.			
Resistance to Soldering Heat	 No visible mechanical damage. Varistor voltage change: within ±10%. 	① Solder temperature: 260±3℃② Duration: 5 sec.			
Coldering Ficat	variator voltage change, within 11070.	The chip shall be stabilized at normal condition for 1~2hours			
		before measuring.			
		④ Solder: Sn/3.0Ag/0.5Cu.			
		⑤ Flux: 25% Resin and 75% ethanol in weight.			
Thermal Shock	No visible mechanical damage. Variates valtage changes within ±100/	① Temperature, Time: -55 ℃ for 30±3 min→125 ℃ for 30±3 min.			
	② Varistor voltage change: within ±10%.	2 Transforming interval: 20sec. (max.)3 Tested cycle: 100 cycles.			
		The chip shall be stabilized at normal condition for 1~2 hours			
	30 min. 30 min.	before measuring.			
	125°C 30 min.				
	Ambient /				
	Temperature 30 min.				
	© 20sec. (max.)				
	20360. (IIIAX.)				
Resistance	No visible mechanical damage. Varietary valtage changes within 110%	① Temperature: -55±2°C			
to Low Temperature	② Varistor voltage change: within ±10%.	 ② Duration: 1000⁺²⁴ hours. ③ The chip shall be stabilized at normal condition for 1~2 hours 			
.omporature		before measuring.			
Resistance	No visible mechanical damage.	① Temperature: 125±2°C.			
to High	② Varistor voltage change: within ±10%.	② Duration: 1000 ⁺²⁴ hours.			
Temperature		③ The chip shall be stabilized at normal condition for 1~2 hours			
Damp Hoot	No visible mechanical demans	before measuring.			
Damp Heat	 No visible mechanical damage. Varistor voltage change: within ±10%. 	Temperature: 60±2°C Humidity: 90% to 95% RH.			
(Steady States)	variotor voltage originge. Within ±1070.	3 Duration: 1000 ⁺²⁴ hours.			
		The chip shall be stabilized at normal condition for 1~2 hours			
		before measuring.			



TESB0R15V05B1X

Loading Under Damp Heat Loading at High Temperature	 No visible mechanical damage. Varistor voltage change: within ±10%. No visible mechanical damage. Varistor voltage change: within ±10%. 	 Temperature: 60±2°C Humidity: 90% to 95% RH. Duration: 1000*24 hours. Applied voltage: DC Working Voltage. The chip shall be stabilized at normal condition for 1~2 hours before measuring. Temperature: 125±2°C Duration: 1000*24 hours.
(Life Test)		 ③ Applied voltage: DC Working Voltage. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.
Maximum Surge Current	No visible mechanical damage. Varistor voltage change: within ±10%. IEC61000-4-5 standard 1.2/50us-8/20us voltage-current combination pulse	 Temperature: 25±5°C Humidity: 30% to 65% RH. Number of hit: each 1 time of +/- polarity. Pulse waveform: 8/20 us. Applied current: maximum surge current (I_P). The chip shall be stabilized at normal condition for 1~2 hours before measuring.
Maximum Surge Energy	No visible mechanical damage. Varistor voltage change: within ±10%. IEC61000-4-5 standard 10/1000us current pulse	 Temperature :25±5°C Humidity: 30% to 65% RH. Number of hit: 1 time. Pulse waveform: 10/1000 us. Applied energy: maximum surge energy (E_T). The chip shall be stabilized at normal condition for 1~2 hours before measuring.
ESD Life	No visible mechanical damage. Varistor voltage change: within ±10%. IEC61000-4-2 standard ESD gun C=150pF R=330Ω	 Discharge: Contact discharge. Voltage: 8000V (Level 4). Polarity: +, Number: 10 times within 10 sec. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
ESD Test	No visible mechanical damage. Varistor voltage change: within ±10%. IEC61000-4-2 standard ESD gun C=150pF R=330Ω	 Discharge: Air discharge. Voltage: 15000V (Special level). Polarity: +, - Number: 10 times within 10 sec. The chip shall be stabilized at normal condition for 1~2 hours before measuring.



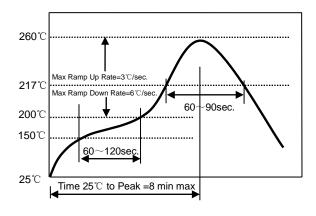
Recommended Soldering Technologies

Reflow Profile:

△ Allowed time above 217C: 60~90sec.

△ Max temp: 260°C

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



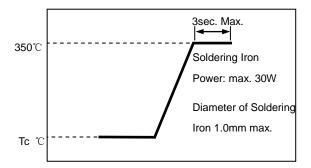
Iron Soldering Profile.

 \triangle Iron soldering power: Max.30W \triangle Pre-heating: 150 $^{\circ}$ C / 60 sec.

△ Soldering Tip temperature: 350°C Max.

△ Soldering time: 3 sec Max.
 △ Solder paste: Sn/3.0Ag/0.5Cu
 △ Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



characteristic curves of chip varistor

